

Notice of References Cited

Application/Control No.

10/068,414

Applicant(s)/Patent Under
Reexamination
FUJII ET AL.

Examiner

Beniyam Menberu

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0061805 A1	04-2004	Shibamiya et al.	348/565
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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